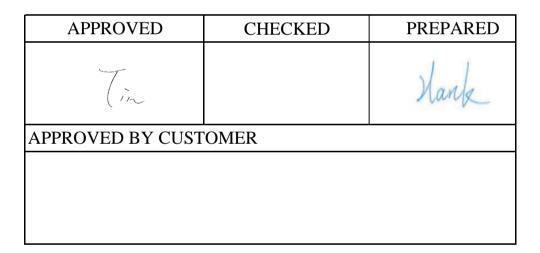
# APPROVAL SHEET

Customer Name	:
Customer P/N	:
Frequency	: 25.000000 MHz
Aker Approved P/N	: SMAN-025000-5-D4-00
Aker MPN	: SMAN-025000-5-D4-00
Rev.	: 1
ISSUE DATE	: Feb.13.2023



# AKER TECHNOLOGY CO., LTD.

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TEL: 886-4-25335978 FAX: 886-4-25336011

Web: www.aker.com.tw

MSL:Level 1 RoHS compliant



Aker Approved I	P/N :	SMAN-	SMAN-025000-5-D4-00			
APPROVED	•	Tin	SHEET : 1 of 10			
PREPARED	•	Hank	REV. : 1			
			Confidential			

		Γ	
Rev.	Date	Reviser	Revise contents
1	2023/2/13	Hank	Initial Released



Aker Approved F	P/N :	SMAN-(	SMAN-025000-5-D4-00				
APPROVED	•	Tin	SHEET : 2 of 10				
PREPARED	:	Hank	REV. : 1				

#### Confidential

# SMD CRYSTAL OSCILLATOR

#### **1. ELECTRICAL CHARACTERISTICS**

■ Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature :  $25\pm5$  °C

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature :  $25\pm3$  °C

Relative humidity : 40%~70%

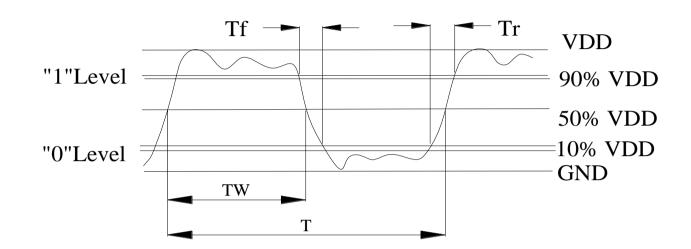
- AKER Model : SMAN-531
- Cutting Mode : AT CUT

			Electrica	al Spec		
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes
Nominal Frequency		2	5.00000	0	MHz	
Frequency Stability			$\pm 50$		ppm	
Supply Voltage	Vcc	1.62	~	3.63	V	
Output Load CMOS	CL			15	pF	
Aging			$\pm 3$		ppm	First Year
Enable Control			Yes			Pad 1
Operating Temperature		-40	25	85	°C	
Storage Temperature Range		-55	~	125	°C	
Output Voltage High	VoH	90%Vdd			V	
Output Voltage Low	VoL			10%Vdd	V	
Input Current	Icc			12	mA	
Standby Current	Ist			10	μA	
Rise Time	Tr			10	ns	10%~90% VDD Level
Fall Time	Tf			10	ns	90%~10% VDD Level
Symmetry (Duty ratio)	TH/T	45	~	55	%	
Start-up Time	Tosc			10	ms	
Enable Voltage High	Vhi	70%Vdd			V	
Disable Voltage Low	Vlo			30%Vdd	V	
Output Enable Delay Time	T on			10	ms	
Output Disable Delay Time	T off			200	ns	
Phase Jitter RMS				1	ps	12KHz~5MHz
*Please kindly be noted that AKER	DO NOT g	uarantee pa	arts qualit	y which in	volves	human security application.*

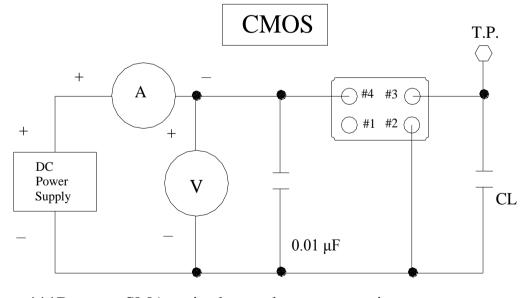


Aker Approved P	P/N :	SMAN-(	SMAN-025000-5-D4-00			
APPROVED	•	Tin	SHEET : 3 of 10			
PREPARED	•	Hank	REV. : 1			
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#### 2. C - MOS LOAD OUTPUT WAVEFORM



## **3.C-MOS LOAD TEST CIRCUIT**



\*\*\*Because SMA series has no by pass capacitor. So,we recommend our customer to use capacitor  $0.01 \ \mu F$  in join Vcc and GND.

	Aker Approv	ed P/N :		SMAN-	025000-3	5-D4-00		
	APPROVED	:		Tin	SHE	EET : 4	of 10	
	PREPARED			Hank	REV	1. :	1	
Accurate Kinetic Energy						Confide	ential	
4. MARKING : W 25.000 AKER AB								
	→ Year/Month	n Code:	Please 1	nake ref	er to foll	lowing ta	ables.	
AKER LOGO.	1	Date Code					1	
		Year	2021 2025	2022	2023	2024		
NOTE1:		Month	(4N+1)	2026 (4N+2)	2027 (4N+3)	2028 (4N+0)		
T 5.0V TTL		JAN	(41(+1)) a	(41(+2) n	A	N		

A cycle every four years

ь

с

d

e

f

g

h

j

k

1

m

p

q

r

s

t

u

v

w

х

y

z

FEB

Mar

Apr

May

Jun

Jul

Aug

Sep

Oct

Nov

Dec

#### **5. DIMENSION :**

С

L

R

S

Y

Ζ

W

#### Enable / Disable Function

E/D (#1)	OUTPUT(#3)
HIGH (Open)	Operating
LOW	High impedance

4.5~5.0V CMOS

2.8~3.0V CMOS

1.5~2.0V CMOS

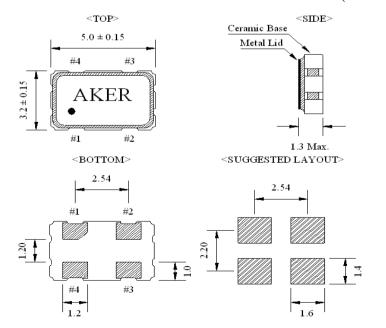
0.8~1.4V CMOS

Voltage Range CMOS

2.25~2.75V CMOS

2.97~3.63V TTL&CMOS

PIN FUNCTION					
#1:Enable / Disable Control					
#2:GND					
#3 : OUTPUT					
#4:VDD					



(UNIT:mm)

в

С

D

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F

G

Н

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L

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Р

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w

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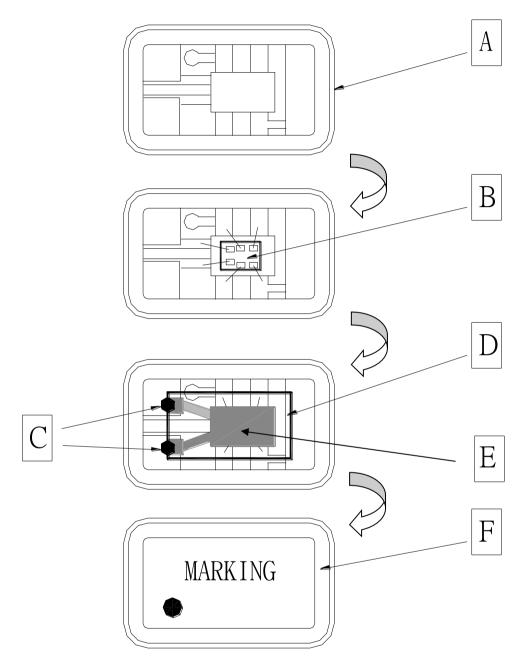
Υ

Z



Aker Approved P/	N :	SMAN-02	SMAN-025000-5-D4-00		
APPROVED	:	Tin	SHEET : 5 of 10		
PREPARED	:	Hank	REV. : 1		
			Confidential		

# **6. STRUCTURE ILLUSTRATION**

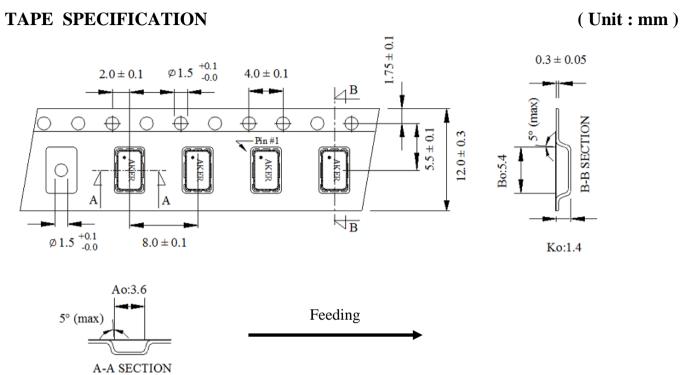


	COMPONENTS	MATERIALS	CO	MPONENTS	MATERIALS
A	Base (Package)	Ceramic (Al2O3)+Kovar (Fe/Co/Ni)	D	Crystal blank	SiO2
В	IC chip		E	Electrode	Cr / Ag
С	Conductive adhesive	Ag / Silicon resin	F	Lid	Fe/Co/Ni



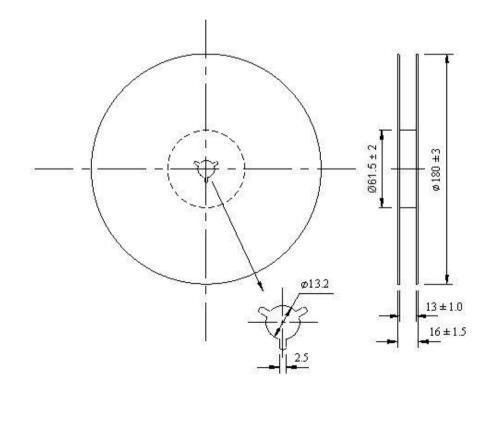
Aker Approved P/N	:	SMAN-025000-5-D4-00			
APPROVED	:	Tin	SHEET : 6 of 10		
PREPARED	:	Hank	REV. : 1		
			Confidential		

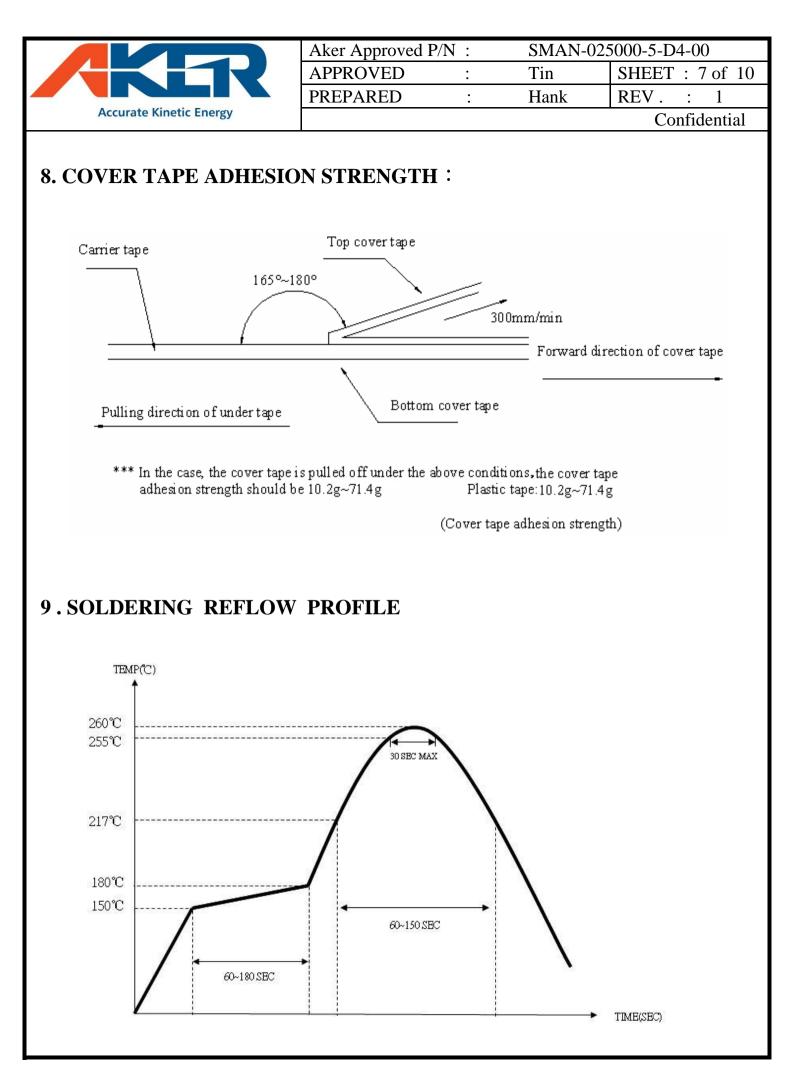
## 7. PACKING :

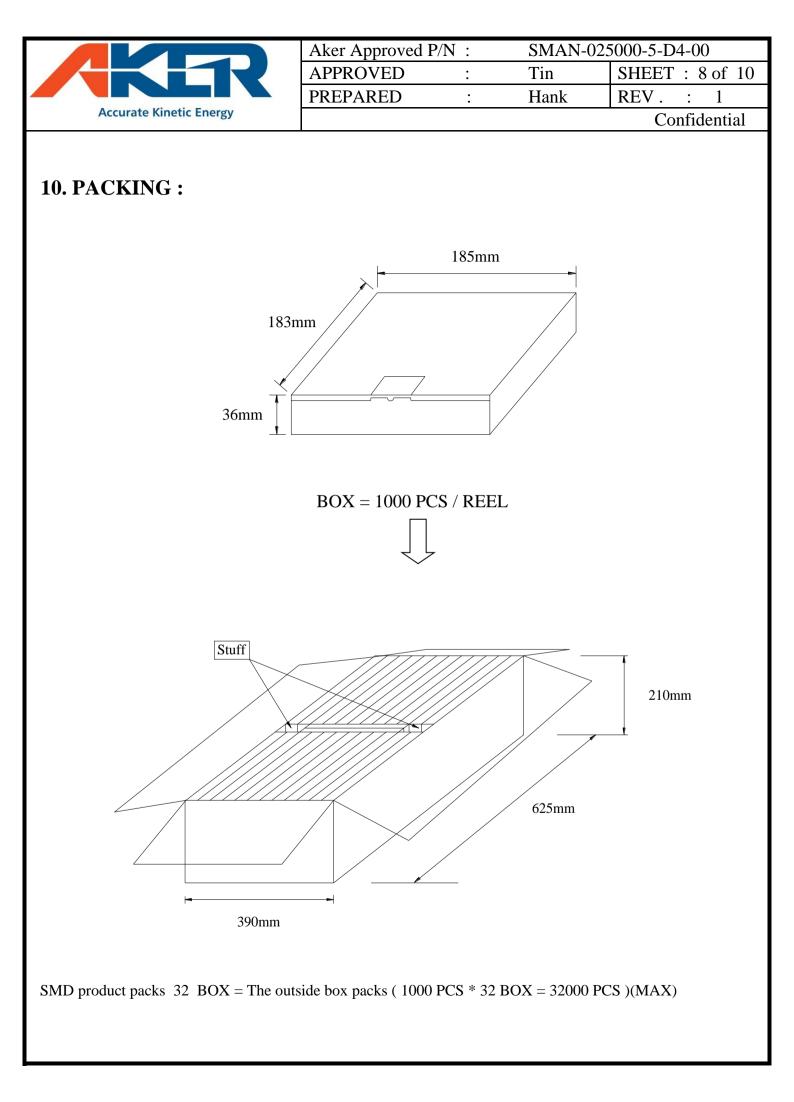


#### **OUTLINE DIMENSION**

(Unit:mm)









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			Confidential	

11. MECHANICAL PERFORMANCE				
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE		
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a hight of 75 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. ( in accordance with JIS-C0044 )			
11.2 Vibration Test	The specimen is measured for its frequency before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range ; 20 ~ 2000HZ Peak to peak amplitude : 1.52 mm Peak acceleration : 20G Sweep time : 20 minute / axis Pendicular total test time : 4 hours ( in accordance with MIL-STD-883F : 2007.3 )	To satisfy the electrical performance .		
11.3 Resistance to Soldering Test	The specimen is measured for its frequency before the test. Place the specimen on the belt of the converynace and let it pass through the reflow with the presetted temperature condition. After passing twice the reflow place, the specimen under the referee condition for -~2 hours and then measure its electrical performance. Temperature Condition of IR Simulation: The temperature range of the preheated section is setted at $150 \ 180^{\circ}$ C for $60 \ 120$ sec. For the next section the temperature range is setted at $217 \ 260^{\circ}$ C for $45 \ 90$ sec. and within this time range the specimen should be able to sustain at the peak temperature, $260 \ -/-3^{\circ}$ C , for 10 sec long. ( in accordance with JESD22-B106-B )			
11.4 Fine Leak Test	<ul> <li>Place the specimen in a pressurized container and pressurize it with the detection gas (mixed gas consisting of 95% or more helium) for at least 2 hours.</li> <li>Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container.</li> <li>( in accordance with MIL-STD-883F : 1014.11 )</li> </ul>	Less than 1.0 * 10 <sup>-8</sup> atm .c.c. / sec, Helium		
	The referee condition . Temperature $25 \pm 2 \degree$ C Humidity $44 \degree 55 \%$ Pressure $86 \degree 106 \text{ kPa}$			

( in accordance with MIL-STD-883E:1014.9 )



Aker Approved P/N :		SMAN-025000-5-D4-00	
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#### **12. CLIMATIC RESISTANCE**

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	The specimen is measured for its frequency before the test . Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours . Take the specimen out of the chamber and measure itselectrical performance after leaving 1 ~ 2 hours under the referee condition. ( in accordance with JIS-C0020 )	
12.2 Aging Test	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and keep it at the temperature of $+125 \pm 3^{\circ}$ C for $720 \pm 48$ hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition . ( in accordance with JIS-C0021 )	To satisfy the electrical performance .
12.3 High Temperature & High Humidty	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5$ °C and humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and then take the specimen out and measure its electrical performance after leaving for $1 \ 2$ hours under the referee condition. ( in accordance with MIL-STD-883F : 1004.7 )	
12.4 Temperature Cycle Test	The specimen is measured for its frequency before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + 125 ± 3 °C (15± 3 min). $2\sim 3 \text{ min}$ Low temp55 ± 3 °C (15± 3 min). Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . ( in accordance with MIL-STD-883F : 1010.8 )	